

AON2240

40V N-Channel MOSFET

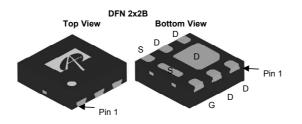
General Description

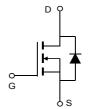
The AON2240 combines advanced trench MOSFET technology with a low resistance package to provide extremely low $R_{\text{DS(ON)}}$. This device is ideal for load switch and battery protection applications.

Product Summary

 $\begin{array}{ll} V_{DS} & 40V \\ I_D \; (at \, V_{GS} \! = \! 10V) & 8A \\ R_{DS(ON)} \; (at \, V_{GS} = \! 10V) & < 21 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} = \! 4.5V) & < 29 m\Omega \end{array}$







Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	40	V
Gate-Source Voltage		V_{GS}	±20	V
Continuous Drain	T _A =25°C	1	8	
Current ^G	T _A =100°C	'D	6	A
Pulsed Drain Current C		I _{DM}	32	
	T _A =25°C	P _D	2.8	W
Power Dissipation ^A	T _A =70°C	- D	1.8	VV
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

Thermal Characteristics								
Parameter		Symbol	Symbol Typ Max		Units			
Maximum Junction-to-Ambient A	t ≤ 10s	D	37	45	°C/W			
Maximum Junction-to-Ambient AD	Steady-State	$\kappa_{\theta JA}$	66	80	°C/W			



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Тур	Max	Units			
STATIC PARAMETERS									
BV _{DSS}	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$	40			V			
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =40V, V _{GS} =0V			1	μΑ			
		T _J =55°C			5				
I_{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V			±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$	1.4	1.9	2.4	V			
$I_{D(ON)}$	On state drain current	V_{GS} =10V, V_{DS} =5V	32			Α			
		V _{GS} =10V, I _D =8A		16.8	21	mΩ			
$R_{DS(ON)}$	Static Drain-Source On-Resistance	T _J =125°C		24.5	31	11122			
		V _{GS} =4.5V, I _D =4A		22.6	29	mΩ			
g _{FS}	Forward Transconductance	V_{DS} =5V, I_{D} =8A		33		S			
V_{SD}	Diode Forward Voltage	I _S =1A,V _{GS} =0V		0.75	1	V			
Is	Maximum Body-Diode Continuous Curr			3.5	Α				
DYNAMIC	PARAMETERS								
C _{iss}	Input Capacitance			415		pF			
Coss	Output Capacitance	V_{GS} =0V, V_{DS} =20V, f=1MHz		112		pF			
C _{rss}	Reverse Transfer Capacitance]		11		pF			
R_g	Gate resistance	V _{GS} =0V, V _{DS} =0V, f=1MHz	1	2.2	3.5	Ω			
SWITCHI	NG PARAMETERS	•							
Q _g (10V)	Total Gate Charge			6.5	12	nC			
Q _g (4.5V)	Total Gate Charge	\/ =10\/ \/ =20\/ =8A		3	6	nC			
Q_{gs}	Gate Source Charge	V_{GS} =10V, V_{DS} =20V, I_{D} =8A		1.2		nC			
Q_{gd}	Gate Drain Charge]		1.1		nC			
$t_{D(on)}$	Turn-On DelayTime			4		ns			
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =20V, R_L =2.5 Ω ,		3		ns			
$t_{D(off)}$	Turn-Off DelayTime	R_{GEN} =3 Ω		15		ns			
t _f	Turn-Off Fall Time]		2		ns			
t _{rr}	Body Diode Reverse Recovery Time	I _F =8A, dI/dt=100A/μs		12.5		ns			
Q _{rr}	Body Diode Reverse Recovery Charge	I _F =8A, dI/dt=100A/μs		3.5		nC			

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_{A} =25° C. The Power dissipation P_{DSM} is based on R_{BJA} t \leq 10s value and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

- D. The $R_{\theta JA}$ is the sum of the thermal impedance from junction to case $R_{\theta JC}$ and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300μs pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T_{J(MAX)}=150° C. The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.

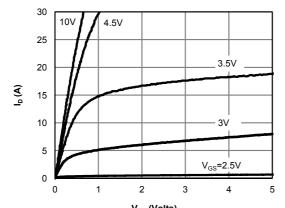
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B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

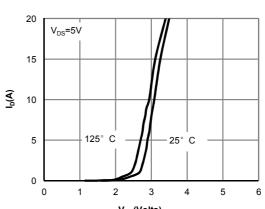
C. Repetitive rating, pulse width limited by junction temperature T_{J(MAX)}=150° C. Ratings are based on low frequency and duty cycles to keep initial T_J =25° C.



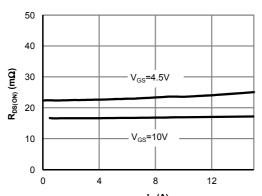
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $\label{eq:VDS} {\rm V_{DS}} \mbox{ (Volts)}$ Fig 1: On-Region Characteristics (Note E)



V_{GS}(Volts) Figure 2: Transfer Characteristics (Note E)



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m I_D}\left({
m A} \right)$ Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

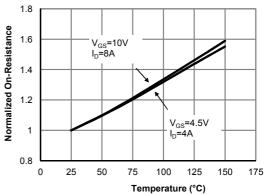
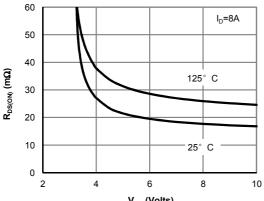
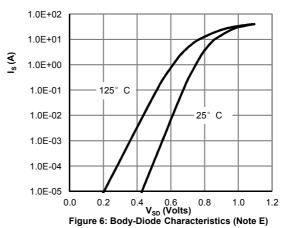


Figure 4: On-Resistance vs. Junction Temperature (Note E)



V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage
(Note E)



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TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

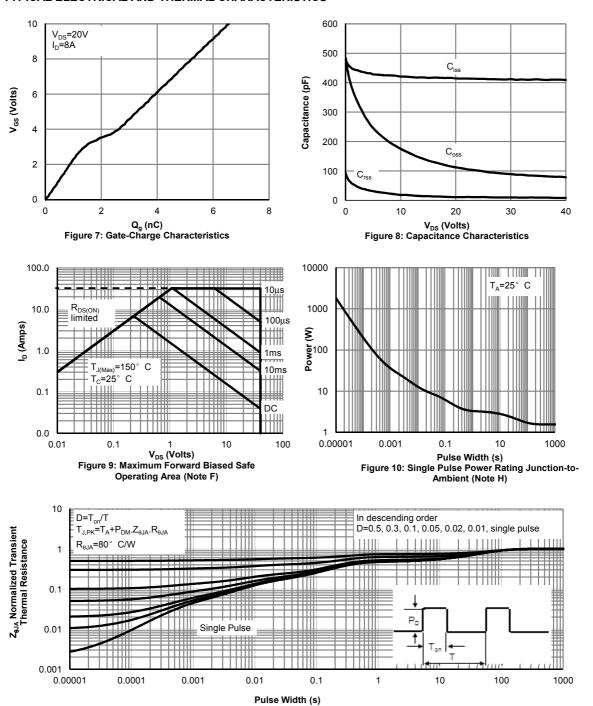
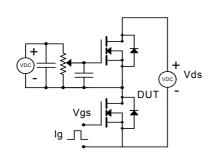
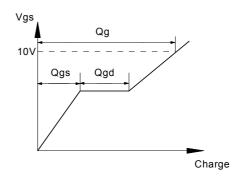


Figure 11: Normalized Maximum Transient Thermal Impedance (Note H)

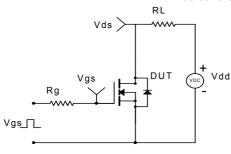


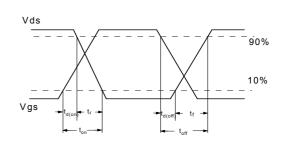
Gate Charge Test Circuit & Waveform



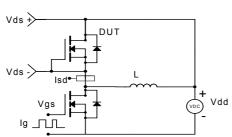


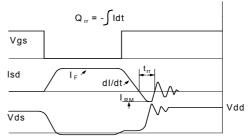
Resistive Switching Test Circuit & Waveforms





Diode Recovery Test Circuit & Waveforms





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